

nanoSXY 400

High speed XY piezo positioner

Concept:

The **nanoSXY 400 stages** have been developed for fast and precise positioning of optical and mechanical components. These systems are specially optimized for very high z-axis stiffness. The special parallel kinematics of the actuator guarantees guidance accuracy at its best.

The FEA designed actuating system, which is based on a hinge flexure design guarantees motion without mechanical play. Overshooting is actively minimized with controllable set and reset forces.

While fully loaded, defined positions can be achieved within a few milli-seconds making these stages an excellent choice for high speed scans used in industrial applications. The **nanoSXY 400** is also available with a capacitive measurement system.

Specials:

The **nanoSXY 400** is temperature compensated, so the stage keeps its position if the surrounding temperature changes.

The bi-directional gear design makes the system very robust and makes it non-sensitive against external forces.

Vacuum and cryogenic versions are available on demand as well as body material variations of invar, super invar, aluminum or titanium.

Mounting:

For stage mounting there are 4 tapped holes and 4 through holes available on the bottom of the actuator. On the top side of the stage the tapped holes and through holes can be used to mount components.



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Image: nanoSXY400CAP

Product highlights:

- travel range 400/320 µm open/closed loop
- excellent guidance accuracy
- high Z-axis stiffness
- central aperture of Ø 12.5 mm

Application examples:

- nano positioning
- material research
- microscopy
- semiconductor test equipment

Options:

- vacuum version
- cryogenic version
- special materials



nanoSXY 400

Technical data

		Unit	nanoSXY 400	nanoSXY 400 CAP	
Part no.		-	T-224-00 T-224-06		
axes		-	X,Y		
motion open loop (±10%)*		μm	400		
motion closed loop (±0.2%)*		μm	- 320		
capacitance**		μF	3.6		
feedback se	ensor	-	-	capacitive	
resolution	open loop***	nm	0	.8	
	closed loop***	nm	-	1	
typ. repeatability		nm	-	9	
resonant frequency X/Y/Z		Hz	300/450/800	280/380/800	
additional load 50g X/Y		Hz	230/350	215/250	
additional load 100 g X/Y		Hz	190/280	180/200	
additional load 300 g X/Y		Hz	125/130	120/125	
stiffness X/Y/Z		N/µm	0.35/0.35/2.5		
max. push/pull force		Ν	75/75		
max. load		Ν	50		
rotational e	error	µrad	5 (about	t all axes)	
dimensions	otational error dimensions (L x W x H)		60 x 60 x 20	60 x 82 x 30	
central aperture		mm	ø 12.5		
voltage range		V	-20 +130		
connector	voltage	-	ODU L3 pin		
	sensor	-	-	LEMO 0S.605	
material		-	stainless steel/aluminum		
weight		g	300	410	

typical value measured with 30V300 nanoX amplifier

** typical value for small electrical field strength

*** The resolution is only limited by the noise of the amplifier and metrology.



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partno.		partname	
T-224-06 (D,E)	nanoSXY 400 CAP	
PT22406	rev. 03	OK: date/sign	
$\ominus \oplus$	scale 1:1	customers drawing piezosystem jena	



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